

**Search Notes**

Application/Control No.

10/014,530

Examiner

Andrew H. Lam

Applicant(s)/Patent under  
Reexamination

YAMAGISHI ET AL.

Art Unit

2624

**SEARCHED**

Class	Subclass	Date	Examiner
358	1.15	7/14/2005	AL
358	1.14	7/14/2005	AL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR